

SHM-950

Miniature, High-Speed ±0.001% Sample-Hold Amplifiers

FEATURES

- 18-Bit accuracy
- · Small 8-pin DIP package
- 800ns max. acquisition time to ±0.001%
- · 200ns max. sample-to-hold settling time to ±0.001%
- · 16MHz small signal bandwidth
- · 90dB feedthrough attenuation
- ±25 picoseconds aperture uncertainty
- · 415mW maximum power dissipation



DATEL's SHM-950 is a high-speed, highly accurate sample/hold designed for precision, high-speed analog signal processing applications. The SHM-950 features excellent dynamic specifications including a maximum acquisition time of only 800 nanoseconds for a 10V step to ±0.001%.

Sample-to-hold settling time, to $\pm 0.001\%$ accuracy, is 200 nanoseconds maximum with an aperture uncertainty of ± 25 picoseconds.

The SHM-950 is a complete sample/hold circuit, containing a precision MOS hold capacitor and a MOSFET switching configuration which results in faster switching and better feedthrough attenuation. Additionally, a FET input amplifier design allows faster acquisition and settling times while maintaining a considerably lower droop rate.



INPUT/OUTPUT CONNECTIONS

PIN	FUNCTION
1	+5V SUPPLY
2	S/H CONTROL
3	ANALOG INPUT
4	ANALOG RETURN
5	-15V SUPPLY
6	ANALOG OUTPUT
7	+15V SUPPLY
8	POWER GROUND

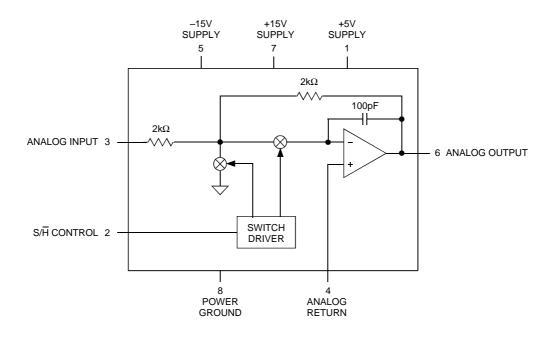


Figure 1. SHM-950 Functional Block Diagram



ABSOLUTE MAXIMUM RATINGS

±15V Supply Voltage +5V Supply Voltage Analog Input	±18V -0.5V to +7V ±18V
Digital Input	-0.5V to +5.5V
Output Current	±65 mA

FUNCTIONAL SPECIFICATIONS

(Apply over the operating temperature range with $\pm 15V$ and $\pm 5V$ supplies unless otherwise specified.)

ANALOG INPUT/OUTPUT	MIN.	TYP.	MAX.	UNITS
Input/Output Voltage Range				
±15V Nominal Supplies	±10	±11.5	_	Volts
±12V Nominal Supplies	±7	±8.5	_	Volts
Input Impedance	1.75	2	_	kΩ
Output Current	_	_	±40	mA
Output Impedance	_	0.1	_	Ω
Capacitive Load	100	250	_	pF
DIGITAL INPUT				<u> </u>
Input Logic Levels				
Logic 1	+2.0	_	+5.0	Volts
Logic 0	0	_	+0.8	Volts
Loading			. 0.0	
Logic 1	_	_	+5	μΑ
Logic 0	_		-5	μΑ
TRANSFER CHARACTERISTIC	S			'
Gain		-1	_	V/V
Gain Error, +25°C	_	±0.05	±0.5	%
Linearity Error ①		±0.001	±0.005	%FS
Sample Mode Offset , +25°C		±2	±7	mV
Sample-to-Hold Offset		12	±1	111 V
(Pedestal), +25°C ②	_	±2.5	±25	mV
Gain Drift	_	±0.5	±15	ppm/°C
Sample Mode Offset Drift ①	_	±3	±15	ppm of
				FSR/°C
Sample-to-Hold Off.		-	20	
(Pedestal) Drift	_	±5	±20	ppm of FSR/°C
DYNAMIC CHARACTERISTICS	<u> </u>			1310 0
Acquisition Time				
10V to ±0.001%FS (±0.1mV) +25°C		1/0	000	no
+25 C -55 to +125°C	_	160	800 900	ns ns
10V to ±0.1%FS (±10 mV)	_	_	700	112
+25°C	_	100	400	ns
-55 to +125°C		- 100	450	ns
10V to ±1%FS (±100 mV)	_	_	430	
10 V (U ±1/01 3 (±100 111V)	_	200	_	n c
` · · · ·	_	200	_	ns ns
1V to ±1%FS (±10 mV)	_ _	200 200	_ _	ns ns
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time	-	200	_ _ 150	ns
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV)	-	200	— — 150 120	ns ns
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV)	 - - -	200 100 100	150 120	ns ns ns
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient	 - - -	200 100 100 100	120 —	ns ns ns mVp-p
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient Aperture Delay Time		200 100 100 100 10	120 — 15	ns ns ns mVp-p ns
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient Aperture Delay Time Aperture Uncertainty (Jitter)		200 100 100 100 10 ±25	120 —	ns ns ns ns mVp-p ns ps
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient Aperture Delay Time Aperture Uncertainty (Jitter) Output Slew Rate		200 100 100 100 10	120 — 15	ns ns ns mVp-p ns
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient Aperture Delay Time Aperture Uncertainty (Jitter) Output Slew Rate Output Droop		200 100 100 100 10 ±25 60	120 — 15 ±50 —	ns ns ns mVp-p ns ps V/µs
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient Aperture Delay Time Aperture Uncertainty (Jitter) Output Slew Rate Output Droop +25°C		200 100 100 100 10 ±25 60 ±0.5	120 — 15 ±50 — ±15	ns ns ns nvp-p ns ps V/µs
1V to ±1%FS (±10 mV) Sample-to-Hold Settling Time 10V to ±0.01%FS (±1 mV) 10V to ±0.1%FS (±10 mV) Sample-to-Hold Transient Aperture Delay Time Aperture Uncertainty (Jitter) Output Slew Rate Output Droop		200 100 100 100 10 ±25 60	120 — 15 ±50 —	ns ns ns mVp-p ns ps V/µs

POWER REQUIREMENTS	MIN.	TYP.	MAX.	UNITS	
Voltage Range					
+15V Supply	+11.5	+15.0	+15.5	Volts	
–15V Supply	-11.5	-15.0	-15.5	Volts	
+5V Supply	+4.75	+5.0	+5.25	Volts	
Power Supply Rejection Ratio	_	±0.5	±1	mV/V	
Quiescent Current Drain					
+15V Supply	_	+8	+13.5	mA	
–15V Supply	_	-8	-13.5	mA	
+5V Supply	_	+1	+1.5	mA	
Power Consumption	_	365	415	m W	
PHYSICAL/ENVIRONMENTAL					
Operating Temp. Range, Case					
SHM-950MC	0 to +70°C				
SHM-950MM	−55 to +125°C				
Storage Temperature Range	−65 to +150°C				
Thermal Impedance					
θjc	15°C/W				
θса		35°C	C/W		
Package Type		8-pin cera	amic DIP		

Footnotes:

- ① Full Scale (FS) = 10V. Full Scale Range (FSR) = 20V.
- ② Sample-to-hold offset error (pedestal) is constant regardless of input/output level.

ORDERING INFORMATION

MODEL	OPERATING TEMP. RANGE		
SHM-950MC	0 to +70°C		
SHM-950MM	−55 to +125°C		
For availability of high-reliability versions of the SHM-950, contact DATEL.			

TECHNICAL NOTES

- All ground pins should be tied together and connected to system analog ground as close to the package as possible. It is recommended to use a ground plane under the device and solder ground pins directly to it. Take care to ensure that no ground potentials can exist between ground pins.
- 2. External $0.1\mu F$ to $1\mu F$ tantalum bypass capacitors are required in critical applications.
- 3. A logic 1 on S/H puts the unit in the sample mode. A logic 0 puts the unit in hold mode.
- 4. The maximum capacitive load to avoid oscillation is typically 250pF. Recommended resistive load is 500Ω , although values as low as 250Ω may be used. Acquisition and sample-to-hold settling times are relatively unaffected by resistive loads down to 250Ω and capacitive loads up to 50pF. Greater load capacitances will affect both acquisition and settling time.
- 5. Gain and offset adjusting can be accomplished using the external circuitry shown in Figure 2. Adjust offset with a 0V input. Adjust gain with a ±FS input. Adjust so that the output in the hold mode matches the input.



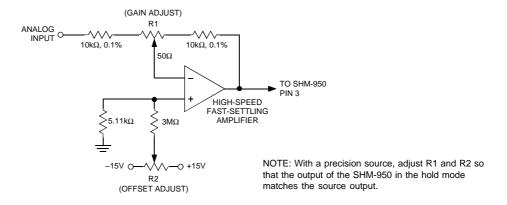
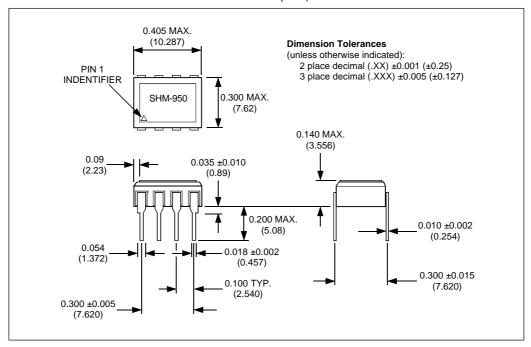


Figure 2. Offset and Gain Adjustments

MECHANICAL DIMENSIONS

INCHES (mm)





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